



ALPHA & OMEGA
SEMICONDUCTOR

AONR21307

30V P-Channel MOSFET

General Description

- Latest advanced trench technology
- Low $R_{DS(ON)}$
- High Current Capability
- RoHS and Halogen-Free Compliant

Product Summary

V_{DS}	-30V
I_D (at $V_{GS}=-10V$)	-24A
$R_{DS(ON)}$ (at $V_{GS}=-10V$)	< 11mΩ
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	< 18.5mΩ

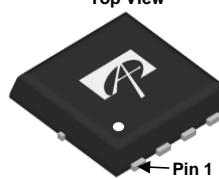
Applications

- Notebook AC-in load switch
- Battery protection charge/discharge

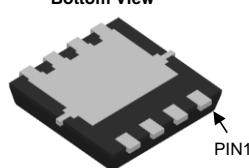
100% UIS Tested
100% R_g Tested



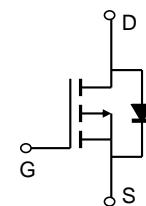
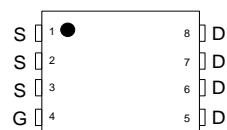
Top View



Bottom View



Top View



Orderable Part Number

AONR21307

Package Type

DFN 3x3 EP

Form

Tape & Reel

Minimum Order Quantity

5000

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 25	V
Continuous Drain Current ^G	I_D	-24	A
$T_C=100^\circ C$		-24	
Pulsed Drain Current ^C	I_{DM}	-82	
Continuous Drain Current	I_{DSM}	-17	A
$T_A=70^\circ C$		-14	
Avalanche Current ^C	I_{AS}	33	A
Avalanche energy $L=0.1\text{mH}$ ^C	E_{AS}	54	mJ
Power Dissipation ^B	P_D	28	W
$T_C=100^\circ C$		11	
Power Dissipation ^A	P_{DSM}	5.0	W
$T_A=70^\circ C$		3.2	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	20	25	°C/W
Maximum Junction-to-Ambient ^{A D}		45	55	°C/W
Maximum Junction-to-Case	$R_{\theta JC}$	3.7	4.5	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}, V_{GS}=0\text{V}$	-30			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-30\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$		-1	-5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm25\text{V}$			±100	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1.3	-1.8	-2.3	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=-10\text{V}, I_D=-17\text{A}$ $T_J=125^\circ\text{C}$	9.2	11	15.2	$\text{m}\Omega$
		$V_{GS}=-4.5\text{V}, I_D=-13\text{A}$		14.7	18.5	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=-5\text{V}, I_D=-17\text{A}$		43		S
V_{SD}	Diode Forward Voltage	$I_S=-1\text{A}, V_{GS}=0\text{V}$		-0.7	-1	V
I_S	Maximum Body-Diode Continuous Current ^G				-24	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=-15\text{V}, f=1\text{MHz}$		1995		pF
C_{oss}	Output Capacitance			300		pF
C_{rss}	Reverse Transfer Capacitance			260		pF
R_g	Gate resistance	$f=1\text{MHz}$		4.5	9	Ω
SWITCHING PARAMETERS						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, I_D=-17\text{A}$		35	50	nC
$Q_g(4.5\text{V})$	Total Gate Charge			17	25	nC
Q_{gs}	Gate Source Charge			5.7		nC
Q_{gd}	Gate Drain Charge			8.8		nC
$t_{D(\text{on})}$	Turn-On DelayTime	$V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, R_L=0.9\Omega, R_{\text{GEN}}=3\Omega$		11		ns
t_r	Turn-On Rise Time			7.5		ns
$t_{D(\text{off})}$	Turn-Off DelayTime			43.5		ns
t_f	Turn-Off Fall Time			17.5		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=-17\text{A}, di/dt=500\text{A}/\mu\text{s}$		13.3		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=-17\text{A}, di/dt=500\text{A}/\mu\text{s}$		20		nC

A. The value of R_{iJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on $R_{iJA} \leq 10\text{s}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$.

D. The R_{iJA} is the sum of the thermal impedance from junction to case R_{iJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

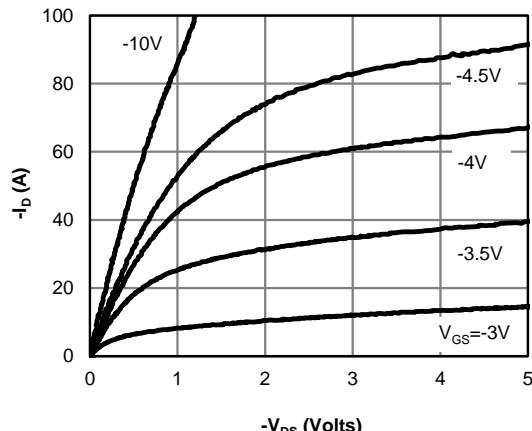
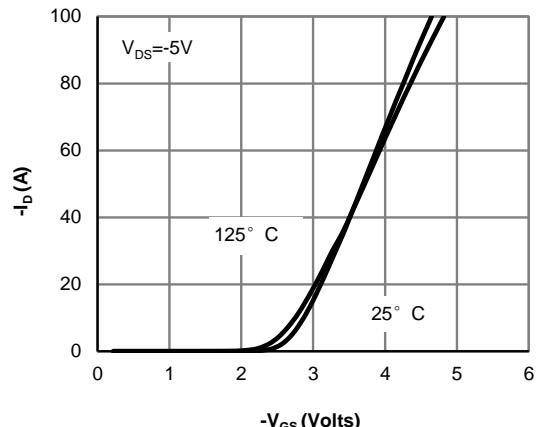
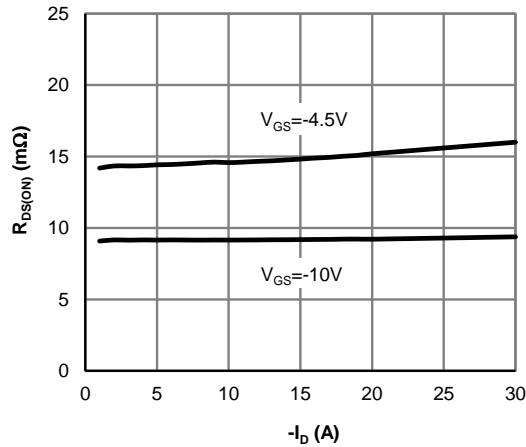
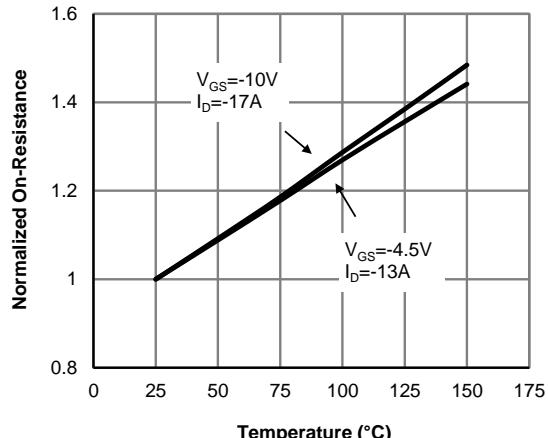
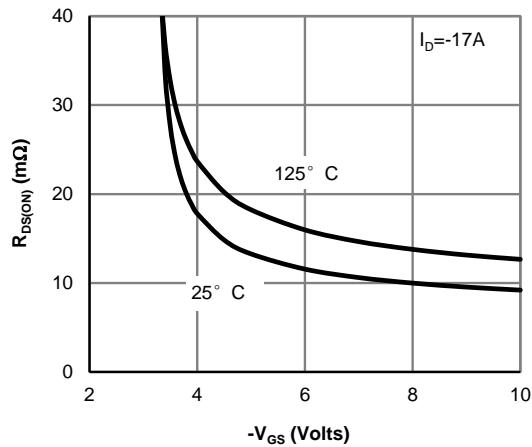
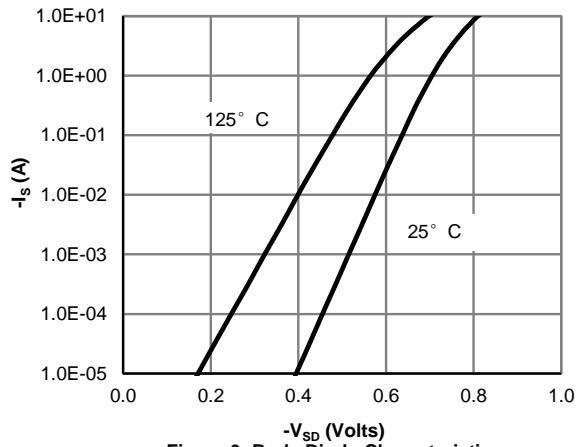
G. The maximum current rating is package limited.

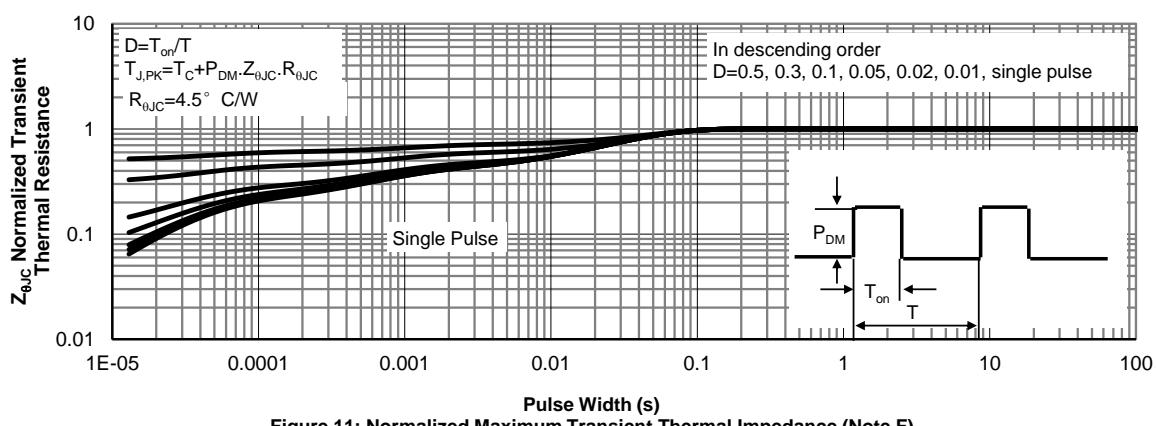
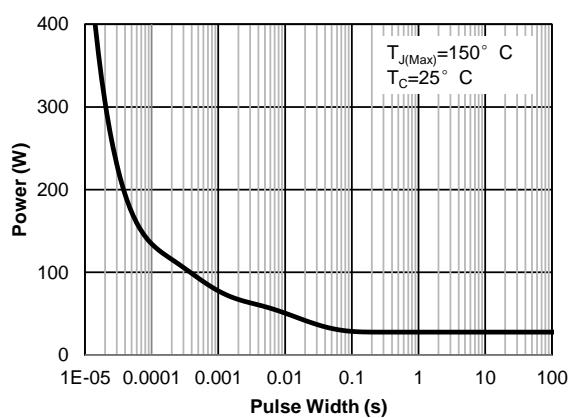
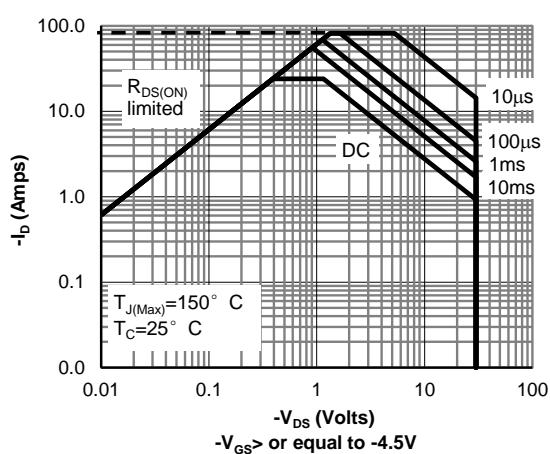
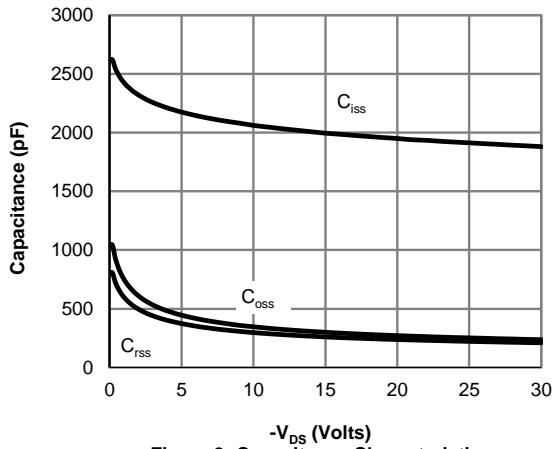
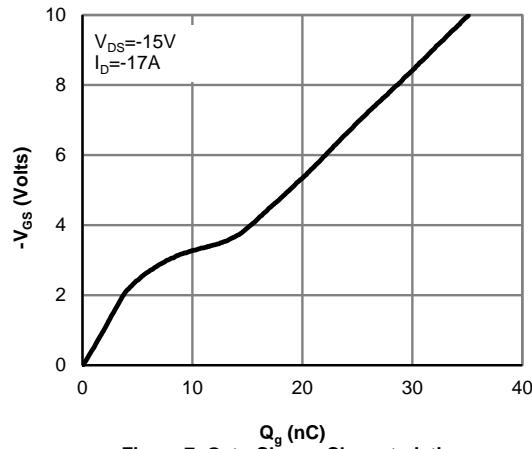
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

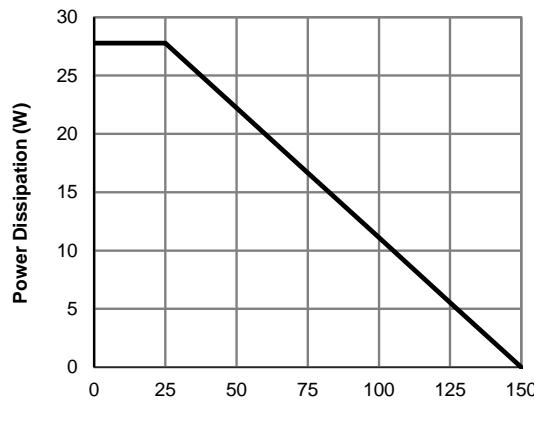
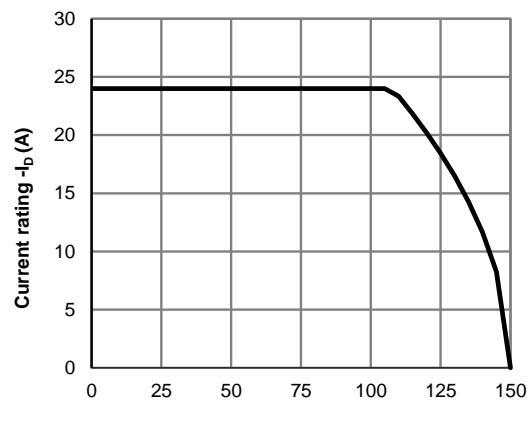
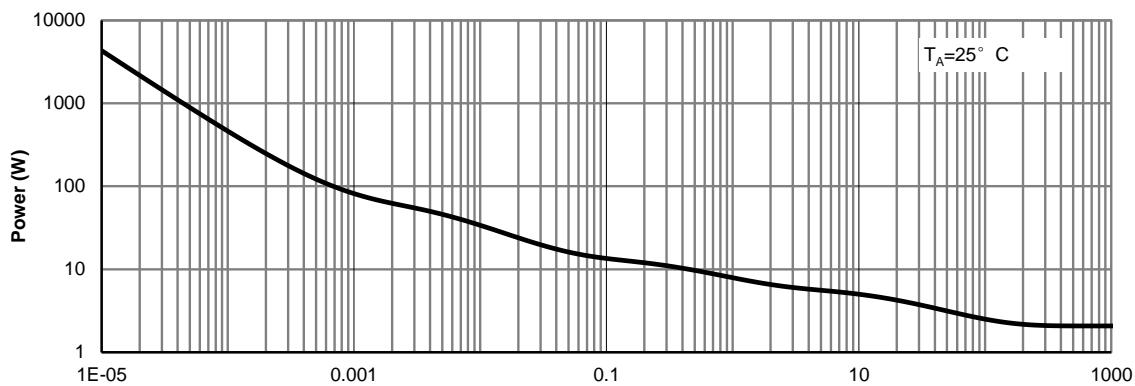
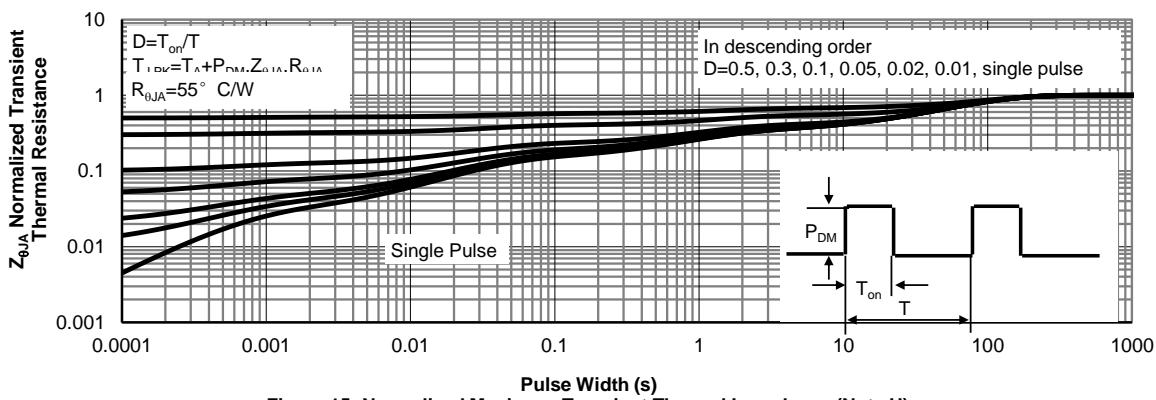
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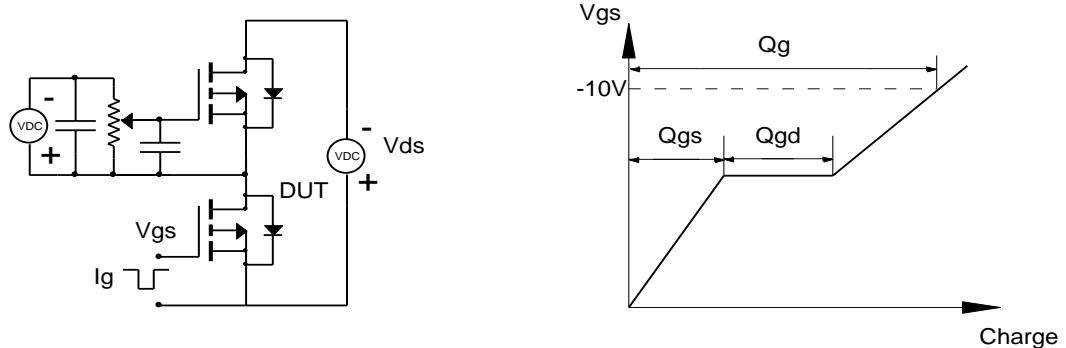
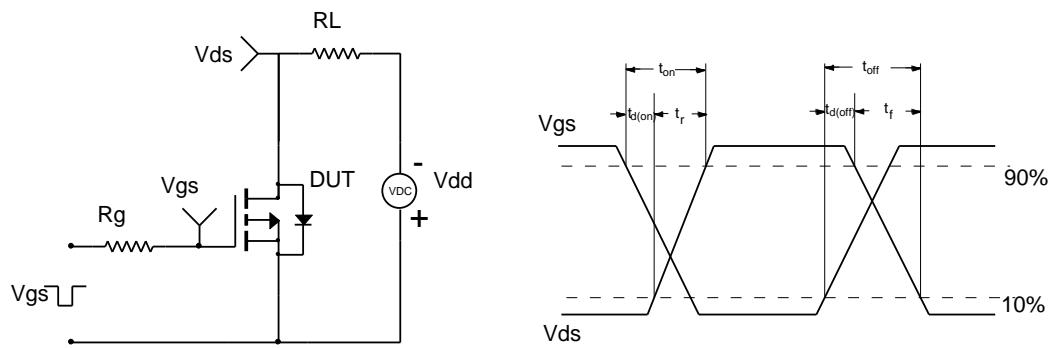
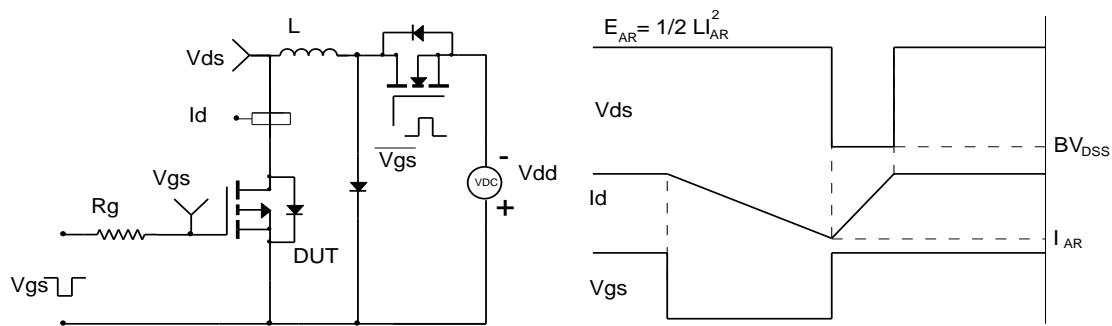
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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics (Note E)

Figure 2: Transfer Characteristics (Note E)

Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

Figure 4: On-Resistance vs. Junction Temperature (Note E)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


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Figure 12: Power De-rating (Note F)

Figure 13: Current De-rating (Note F)

Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
